

Search Notes

Application/Control No.

10/840,110

Examiner

OANH DUONG

Applicant(s)/Patent under
Reexamination

WEEL, MARTIN

Art Unit

2455

SEARCHED

Class	Subclass	Date	Examiner
709	203,217,2 19,231- 232	1/27/2009	O.D
725	38	1/27/2009	o.d

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search of USPAT, JPO, EPO, DERWENT, IBM_TDB, US- PGPUB	1/27/2009	o.d